Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

214607US2

SERIAL NO.

09/964,585

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Toyoji IKEZAWA, et al.

FILING DATE

September 28, 2001

GROUP

2171

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>Edik</i>	AO	2001-250022	09/14/2001	JAPAN (with English translation)		
<i>↓</i>	AP	2000-242724	09/08/2000	JAPAN (with English translation)		
<i>↓</i>	AQ	9-160979	06/20/97	JAPAN (with English translation)		
<i>↓</i>	AR	9-6838	01/10/97	JAPAN (with English translation)		
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

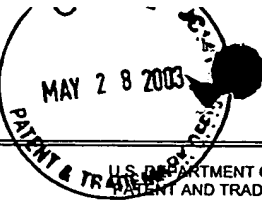
Examiner

*E. P. Lehoucq*

Date Considered

2/12/04

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 214607US2		SERIAL NO. 09/964,585	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Toyoji IKEZAWA, et al.			
				FILING DATE September 28, 2001		GROUP 2171	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<i>Elh</i>	AO	10-011498	01/16/98	JAPAN (with English Abstract)			X
<i>Elh</i>	AP	07-230442	08/29/95	JAPAN (with English Abstract)			X
<i>Elh</i>	AQ	2000-222486	08/11/2000	JAPAN (with English Abstract)			X
	AR						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
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	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner <i>SP Lihana</i>					Date Considered <i>2/12/04</i>		
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